

# **ZXTN19060CG** 60V NPN low sat medium power transistor in SOT223

## Summary

 $BV_{CEO} > 60V$ 

**BV<sub>CEX</sub> > 160V** 

 $BV_{ECO} > 6V$ 

 $I_{C(cont)} = 7A$ 

V<sub>CE(sat)</sub> < 50mV @ 1A

 $R_{CE(sat)} = 30m\Omega$ 

 $P_{D} = 3.0W$ 



## Complementary part number ZXTP19060CG

## **Description**

Packaged in the SOT223 outline this new low saturation NPN transistor offers extremely low on state losses making it ideal for use in DC-DC circuits and various driving and power management functions.

## **Features**

- Higher power dissipation SOT223 package
- · High peak current
- · Low saturation voltage
- 160V forward blocking voltage
- · 6V reverse blocking voltage

## **Applications**

- · Motor drive
- · Lamp, relay and solenoid drive

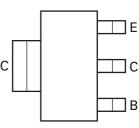
# **Ordering information**

Device	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXTN19060CGTA	7	12	1000

# Pinout - top view

## **Device marking**

ZXTN19 060C



# **Absolute maximum ratings**

Parameter	Symbol	Limit	Unit	
Collector-Base voltage	V <sub>CBO</sub>	160	V	
Collector-Emitter voltage (forward blocking)	V <sub>CEX</sub>	160	V	
Collector-Emitter voltage	V <sub>CEO</sub>	60	V	
Emitter-Collector voltage (reverse blocking)	V <sub>ECX</sub>	6	V	
Emitter-Base voltage	V <sub>EBO</sub>	7	V	
Continuous Collector current(c)	Ic	7	Α	
Base current	I <sub>B</sub>	1	А	
Peak pulse current	I <sub>CM</sub>	12	Α	
Power dissipation at T <sub>A</sub> =25°C <sup>(a)</sup>	P <sub>D</sub>	1.2	W	
Linear derating factor		9.6	mW/°C	
Power dissipation at T <sub>A</sub> =25°C <sup>(b)</sup>	P <sub>D</sub>	1.6	W	
Linear derating factor		12.8	mW/°C	
Power dissipation at T <sub>A</sub> =25°C <sup>(c)</sup>	P <sub>D</sub>	3.0	W	
Linear derating factor		24	mW/°C	
Power dissipation at T <sub>A</sub> =25°C <sup>(d)</sup>	P <sub>D</sub>	5.3	W	
Linear derating factor		42	mW/°C	
Power dissipation at T <sub>C</sub> =25°C <sup>(e)</sup>	P <sub>D</sub>	10.2	W	
Linear derating factor		81	mW/°C	
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 to 150	°C	

## Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient <sup>(a)</sup>	$R_{\Theta JA}$	104	°C/W
Junction to ambient <sup>(b)</sup>	$R_{\Theta JA}$	78	°C/W
Junction to ambient <sup>(c)</sup>	$R_{\Theta JA}$	42	°C/W
Junction to ambient <sup>(d)</sup>	$R_{\Theta JA}$	23.5	°C/W
Junction to case <sup>(e)</sup>	$R_{\Theta JC}$	12.3	°C/W

### NOTES:

<sup>(</sup>a) For a device surface mounted on 15mm x 15mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

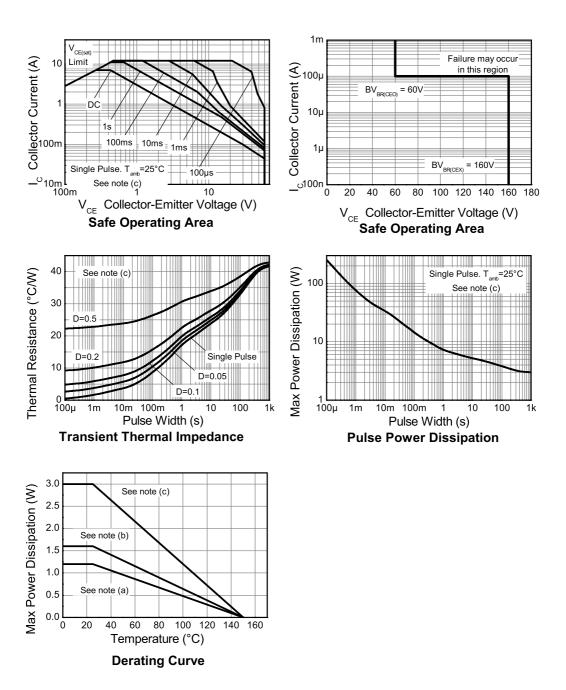
<sup>(</sup>b) Mounted on 25mm x 25mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

<sup>(</sup>c) Mounted on 50mm x 50mm x 0.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.

<sup>(</sup>d) As (c) above measured at t<5 seconds.

<sup>(</sup>e) Junction to case (collector tab). Typical

## Thermal characteristics



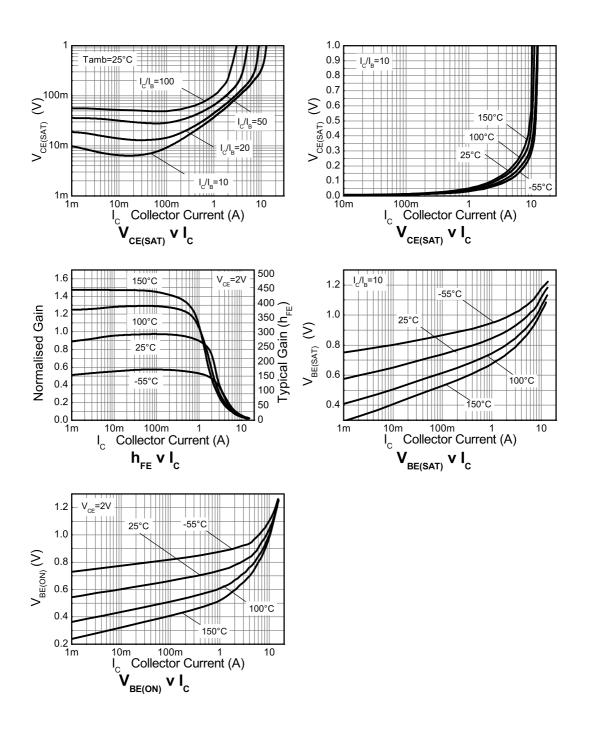
# Electrical characteristics (at $T_{amb} = 25$ °C unless otherwise stated).

	Symbol	Min.	Тур.	Max.	Unit	Conditions
	BV <sub>CBO</sub>	160	200		V	$I_C = 100 \mu A$
voltage	D) /	100	000		.,	1 100 1 5 110
Collector-Emitter breakdown voltage	BV <sub>CEX</sub>	160	200		V	$I_C = 100\mu$ A, $R_{BE} < 1$ kΩ
(forward blocking)						or 1\/ -\/ - 0.25\/
-	D\/	60	75		V	-1V < V <sub>BE</sub> < 0.25V
breakdown voltage	BV <sub>CEO</sub>	60	75		V	I <sub>C</sub> = 10mA <sup>(*)</sup>
	BV <sub>ECX</sub>	6	7		V	$I_F = 100 \mu A$ , $R_{BC} < 1 k \Omega$
Breakdown Voltage	- · LCX	-	-		-	or
(Reverse Blocking)						$0.25V > V_{BC} > -0.25V$
Emitter-Collector	BV <sub>ECO</sub>	6	7		V	I <sub>F</sub> = 100μA
breakdown voltage						
(reverse blocking)						
	BV <sub>EBO</sub>	7	8.3		V	$I_E = 100 \mu A$
voltage Collector-Base cut-off			<1	50	nA	V <sub>CB</sub> = 160V
current	I <sub>CBO</sub>		< 1	0.5	μA	
						V <sub>CB</sub> = 160V, T <sub>amb</sub> = 100°C
Collector-Emitter cut-off current	I <sub>CEX</sub>			100	nA	$V_{CE} = 160V, R_{BE} < 1k\Omega$
Current						or -1V < V <sub>BE</sub> < 0.25V
Emitter cut-off current	I <sub>EBO</sub>		<1	50	nA	$V_{FB} = 5.6V$
Collector-Emitter			37	50	mV	$I_C = 1A$ , $I_B = 100 \text{mA}^{(*)}$
saturation voltage	V <sub>CE(sat)</sub>		105	155	mV	$I_C = 1A$ , $I_B = 100 \text{ mA}^{(*)}$
			110	150	mV	$I_C = 1A$ , $I_B = 10 \text{ mA}^{(*)}$ $I_C = 2A$ , $I_B = 40 \text{ mA}^{(*)}$
			200	300	mV	$I_C = 7A$ , $I_B = 700 \text{mA}^{(*)}$
Base-Emitter saturation	V25( )		1050	1150	mV	_
voltage	V <sub>BE(sat)</sub>		1030	1130	1117	$I_C = 7A$ , $I_B = 700 \text{mA}^{(*)}$
<u> </u>	V <sub>BE(on)</sub>		960	1050	mV	$I_C = 7A$ , $V_{CE} = 2V^{(*)}$
voltage	BE(OII)					.C 774, 10E = 1
Static forward current	h <sub>FE</sub>	200	300	500		$I_C = 100 \text{mA}, V_{CE} = 2V^{(*)}$
transfer ratio		160	220			$I_C = 2A$ , $V_{CE} = 2V^{(*)}$
		25	40			$I_C = 7A$ , $V_{CE} = 2V^{(*)}$
Transition frequency	f <sub>T</sub>		130		MHz	$I_C = 50 \text{mA}, V_{CE} = 10 \text{V}$
						f = 100MHz
Input capacitance	C <sub>ibo</sub>		310	400	pF	V <sub>EB</sub> = 0.5V, f = 1MHz <sup>(*)</sup>
Output capacitance	C <sub>obo</sub>		19.7	25	pF	V <sub>CB</sub> = 10V, f = 1MHz <sup>(*)</sup>
	t <sub>d</sub>		27.3		ns	
Rise time	t <sub>r</sub>		13.2		ns	$I_C = 500 \text{mA}, V_{CC} = 10 \text{V},$
Storage time				l		$I_{B1} = -I_{B2} = 50 \text{mA}$
	$t_s$		682		ns	181 - 182 - 301117 (

### NOTES

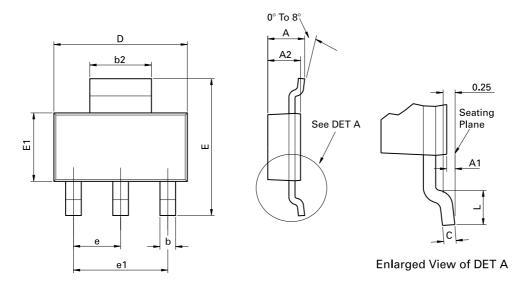
(\*) Measured under pulsed conditions. Pulse width  $\leq 300 \mu s;$  duty cycle  $\leq 2\%.$ 

# **Typical characteristics**



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# Package outline - SOT223



Conforms to JEDEC TO-261 AA Issue B

Dim.	Millin	neters	Inc	hes	Dim.	Millimeters		Inches	
Diiii.	Min.	Max.	Min.	Max.	Diiii.	Min.	Max.	Min.	Max.
Α	-	1.80	-	0.071	D	6.30	6.70	0.248	0.264
A1	0.02	0.10	0.0008	0.004	е	2.30 BSC		0.0905 BSC	
A2	1.55	1.65	0.0610	0.0649	e1	4.60 BSC		0.181 BSC	
b	0.66	0.84	0.026	0.033	E	6.70	7.30	0.264	0.287
b2	2.90	3.10	0.114	0.122	E1	3.30	3.70	0.130	0.146
С	0.23	0.33	0.009	0.013	L	0.90	-	0.355	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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Europe	Americas	Asia Pacific	Corporate Headquarters
Zetex GmbH	Zetex Inc	Zetex (Asia Ltd)	Zetex Semiconductors plc
Kustermann-park	700 Veterans Memorial Highway	3701-04 Metroplaza Tower 1	Zetex Technology Park, Chadderton
Balanstraße 59	Hauppauge, NY 11788	Hing Fong Road, Kwai Fong	Oldham, OL9 9LL
D-81541 München Germany	USA	Hong Kong	United Kingdom
Telefon: (49) 89 45 49 49 0	Telephone: (1) 631 360 2222	Telephone: (852) 26100 611	Telephone: (44) 161 622 4444
Fax: (49) 89 45 49 49 49	Fax: (1) 631 360 8222	Fax: (852) 24250 494	Fax: (44) 161 622 4446
europe.sales@zetex.com	usa.sales@zetex.com	asia.sales@zetex.com	hq@zetex.com

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